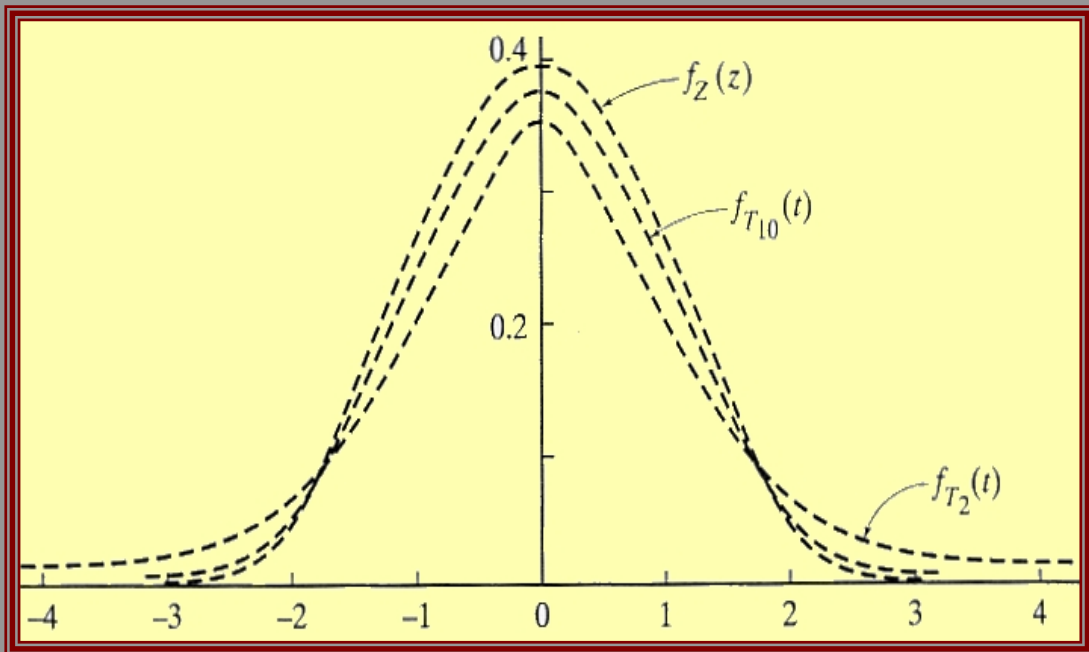


J P S S

A comprehensive journal of probability and statistics
for theorists, methodologists, practitioners, teachers, and others



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Appendix

On the Weak Law of Large Numbers for Double Arrays of Banach Space Valued Random Elements

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ABSTRACT The aim of this paper is to extend the “classical degenerate convergence criterion” and the Feller weak law of large numbers to adapted double arrays of p -uniformly smooth Banach space valued random elements. Our result is more general and stronger than some well-known ones.

Keywords P -uniformly smooth Banach space; Doubly adapted array of random elements; Weak law of large numbers; Convergence in probability; Martingale difference; Sum of i.i.d. random elements.

1. Introduction

The WLLN has been extended to array of random variables or random elements (for random variables, see Hong and Lee [7], Hong and Oh [8], Sung [13], and Sung *et al.* [14, 15]; for random elements, see Adler *et al.* [1, 2], Ahmed *et al.* [3], Hong *et al.* [9, 11], and Sung *et al.* [14, 15]). The aim of this paper is to extend the “classical degenerate convergence criterion” and the Feller weak law of large numbers to adapted double arrays of p -uniformly smooth Banach space valued random elements. Our result is more general and stronger than some well-known ones.

Let us begin with some notations and definitions. Throughout this paper, the symbol C will denote a generic constant ($0 < C < \infty$) which is not necessarily the same one in each appearance. A real separable Banach space \mathbf{E} is said to be p -uniformly smooth ($1 \leq p \leq 2$) if

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AMS 2000 Subject Classifications: 60F05, 60G50, 60G42.

Some Shrunken Testimators for the Variance of a Normal Distribution in Double Stage Samples under an Asymmetric Loss Function

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ABSTRACT The present paper investigates the properties of some shrunken testimators for the variance of a normal distribution in double stage samples, when initial estimate of variance σ^2 is available in the form of point estimate σ_0^2 and their risks are compared with an improved estimator under the asymmetric loss function.

Keywords Normal distribution; Shrunken testimator; Shrunken factor; LINEX loss function and level of significance.

1. Introduction

Let x_{1i} ($i=1,2,\dots,n_1$) and x_{2j} ($j=1,2,\dots,n_2$) be the two independent random samples of size n_1 and n_2 respectively, drawn from a normal distribution with mean μ and variance σ^2 . The unbiased estimator for σ^2 based on sample i of size n_i , $i=1,2$, is

$$s_i^2 = \frac{1}{v_i} \sum_{j=1}^{n_i} (x_{ij} - \bar{x}_i)^2$$

with $MSE(s_i^2) = 2\sigma^4 / v_i$, where $v_i = n_i - 1$. The pooled unbiased estimator for σ^2 based on two samples of size n_1 and n_2 is

$$S^2 = \frac{v_1 s_1^2 + v_2 s_2^2}{v_1 + v_2}$$

with $MSE(S^2) = 2\sigma^4 / (v_1 + v_2)$.

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A Note on the Maximum Likelihood Box-Cox Transformation Parameter

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ABSTRACT The Box-Cox transformation is a well-known family of power transformations that brings a set of data into agreement with the normality assumption of the residuals and hence the response variable of a postulated model in regression analysis. This paper points out a potential innocent mistake in maximizing the likelihood in obtaining the transformation parameter using the Newton-Raphson method and gives an accurate algorithm while using the Newton-Raphson root finding method. In addition, a workable bound of the transformation parameter is suggested which can be used in the grid search method to obtain a more accurate estimate.

Keywords Moments for the ordered standard normal variates; Normality tests; Shapiro-Wilk W statistic.

1. Introduction

In regression analysis, often the key assumption regarding normality of the error variable and hence the response variable are violated. The commonly used remedy is the Box-Cox family of power transformations (see [2]). The process is to select a parameter in the Box-Cox transformation which maximizes the normal likelihood using the data at hand and then apply regression analysis on the transformed response variable. There is no role of the estimates of the location and the scale parameters which were derived in the process of estimating the power transformation parameter in regression analysis. In practice, the regression model parameters are usually estimated separately after the necessary Box-Cox power transformation parameter is selected.

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Simplified Estimating Functions for Discretely Sampled IG-OU Processes

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ABSTRACT The set of IG-OU processes is an important subclass of non-Gaussian processes of Ornstein-Uhlenbeck type, which are recommended to model the volatility of financial assets. After proving self-decomposability of the transition distribution of IG-OU processes, conditional moments are obtained. For the discretely sampled IG-OU process, we propose to use an estimating function, which is based on both a simple estimating function and a martingale estimating function, to estimate the parameter. The simple estimating function is constructed by the score function of the marginal distribution of the process, and the martingale estimating function is constructed by using properties of conditional moments of the process. The consistency and asymptotic normality of the estimator are also discussed. In addition, the theoretical study is validated by simulations.

Keywords Asymptotic normality; Consistency; Estimating function; Inverse Gaussian; Process of Ornstein-Uhlenbeck type; Self-decomposability.

1. Introduction

Non-Gaussian processes of Ornstein-Uhlenbeck type form an important subclass of Markov processes with jumps. Certain of these processes are recently introduced into the financial literature by Barndorff-Nielsen and Shephard [2, 3]. In this paper, we consider the stochastic volatility process suggested in [2], which is given by the solution to the following differential equation:

$$dX(t) = -\lambda X(t)dt + dZ(\lambda t), \quad (1.1)$$

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AMS 2000 Subject Classifications: 62M05, 60G17.

On a Matrix-Variate Generalized Type-1 Dirichlet Model

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ABSTRACT A generalized matrix-variate Dirichlet integral over a random matrix and the associated probability density are examined and a large number of properties of the density are studied. The extension considered is different from the extensions of Dirichlet probability model considered by other authors. The model proposed is shown to be mathematically and statistically interesting with potential for applications in many areas.

Keywords Random matrix; Generalized Dirichlet model; Real matrix-variate distributions; Jacobians of matrix transformations.

1. Introduction

The standard real scalar type-1 Dirichlet density with the parameters $(\alpha_1, \dots, \alpha_k; \alpha_{k+1})$ is given by

$$f(x_1, \dots, x_k) = c_k x_1^{\alpha_1-1} \cdots x_k^{\alpha_k-1} (1 - x_1 - \cdots - x_k)^{\alpha_{k+1}-1}, \quad (1)$$

for $x_i \geq 0, i = 1, \dots, k, x_1 + \cdots + x_k \leq 1, \Re(\alpha_j) > 0, j = 1, \dots, k+1$ and $f_1(x_1, \dots, x_k) = 0$ elsewhere, where $\Re(\cdot)$ denotes the real part of (\cdot) . In statistical problems, usually the parameters are real. Then the conditions reduce to $\alpha_j > 0, j = 1, \dots, k+1$. Since the results are available for the parameters in the complex domain, we will keep the conditions $\Re(\alpha_j) > 0, j = 1, \dots, k+1$. The normalizing constant c_k can be evaluated by integrating out variables one at a time and it is such that

$$c_k^{-1} = \frac{\Gamma(\alpha_1) \cdots \Gamma(\alpha_{k+1})}{\Gamma(\alpha_1 + \cdots + \alpha_{k+1})}.$$

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Autoregressive Processes of Order p with Values on the Positive Half-Line

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ABSTRACT We introduce a class of \mathbf{R}_+ -valued autoregressive processes of order p (AR(p)) by using the generalized multiplication $\odot_{\mathcal{C}}$ of van Harn and Steutel [9]. Stationary AR(p) processes with Mittag-Leffler-type marginal distributions are developed. It is shown in particular that these processes are uniquely defined if one assumes a specialized form of Self-decomposability on the marginal distribution. An \mathbf{R}_+ -valued stationary AR(p) process with a compound-exponential marginal is presented. Related integer-valued AR(p) processes are also discussed.

Keywords Autoregressive; Stationarity; Semigroup; Self-decomposability; Mittag-Leffler distribution.

1. Introduction

Lawrance and Lewis [11] introduced the autoregressive processes of order p (AR(p)):

$$X_n = \begin{cases} \eta_1 X_{n-1} + \varepsilon_n & \text{with probability } c_1, \\ \eta_2 X_{n-2} + \varepsilon_n & \text{with probability } c_2, \\ \dots & \dots \\ \eta_p X_{n-p} + \varepsilon_n & \text{with probability } c_p, \end{cases} \quad (1)$$

where $(\varepsilon_n, n \in \mathbf{Z})$ is a sequence of iid \mathbf{R}_+ -valued rv's, $0 < \eta_i < 1$, $0 \leq c_i \leq 1$, $i = 1, 2, \dots, p$ and $c_1 + \dots + c_p = 1$. The authors obtained the distribution of the innovation sequence $(\varepsilon_n, n \in \mathbf{Z})$ for the stationary AR(2) process with an exponential marginal as a solution to a functional equation. Using the

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Simulation of the Log-Likelihood Random Variables with Applications

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ABSTRACT Likelihood functions guide the analysis in almost all areas of statistical applications. The distribution of the log-likelihood random variable is developed for the location, the scale and the location-scale normal models and algorithms for generating random numbers from these distributions are provided. Simulation results, using the R language, are presented and a new method of likelihood based confidence region construction is developed.

Keywords Likelihood function; Log-likelihood function; Sample distributions; Random number generators; The R language; The duality between tests and confidence regions.

1. Introduction

With model $f_\theta(x)$, the observed likelihood function from x_0 is $cf_\theta(x_0)$ where c is an arbitrary positive constant; this can be formalized in terms of an equivalence class $L_\theta(x_0) = \{cf_\theta(x_0), c \in \mathbb{R}^+\}$ of functions on the parameter space, say Ω . One way of avoiding the nuisance constant c is to choose a representative from the equivalence class. For example, if there is a θ_0 in Ω for which $f_{\theta_0}(x) > 0$ for all sample points, then we can use the explicit representative $\ell_\theta(x_0) = f_\theta(x_0)/f_{\theta_0}(x_0)$ in place of the equivalence class, see Fraser [3]. Barndorff-Nielsen *et al.* [1], in a similar fashion, use the Radon-Nikodym derivative $q_\theta(x_0)$ with respect to a finite dominating measure as an appropriate expression of the likelihood function. McDunnough and Naderi [5] have shown that $L_\theta(x_0)$ and $q_\theta(x_0)$ (and in a similar fashion $\ell_\theta(x_0)$) induce the same partition of the sample space as that used by Lehmann and Scheffé [4] in their construction of the minimal sufficient statistics. If X is a random vector that

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A Discrete Linear Trend-Change Model for Unequally Spaced Data

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ABSTRACT Here a change-point model is presented for detecting changes in the linear trend of unequally spaced time-dependent data. Unobservable errors in the data are modeled by the Ornstein-Uhlenbeck process. No assumptions are made about the unknown parameters in the model. All unknown parameters in the model are estimated by employing the method of maximum likelihood estimation. Testing the significance of the unknown change-point is accomplished by using the likelihood ratio test. Two real world data sets, the U.S. graduate enrollments and the growth of body mass index for the U.S. preschool children, are analyzed which illustrates the usefulness of the proposed model.

Keywords Body mass index; Change-point; Graduate enrollment; Likelihood ratio test; Linear trend; Ornstein-Uhlenbeck process.

1. Introduction

Time-trend analysis is a very important tool for studying economic time series or investigating epidemiologic issues. For example, a need for trend detection and forecasting is desirable by medical doctors working in the renal intensive therapy unit where relatively sudden and unexpected deaths have occurred during the night when there is less medical and nursing cover (Hill-Endresen [14]). Moreover, if data are collected over an extended period, in either cross sectional or prospective studies, time trends in laboratory measurements can have

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Recurrence Relations for Moment Generating Functions of Generalized Order Statistics from Doubly Truncated Continuous Distributions

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ABSTRACT In this paper, a recurrence relation for joint moment generating functions of generalized order statistics, based on a random sample drawn from a class of doubly truncated continuous distributions, is obtained. Joint moments of generalized order statistics (ordinary order statistics and k -records) have been obtained. Recurrence relations for single and product moment generating functions and joint moments of generalized order statistics have been derived. Results for joint moment generating functions and joint moments of generalized order statistics from a number of doubly truncated distributions such as three parameters inverted Weibull (exponential, Rayleigh as special cases), logistic, extreme-value, inverted Pareto, among others, can be derived as special cases of our results. Specializations to right, left and non-truncated classes of continuous distributions have been made.

Keywords Generalized order statistics; Order statistics; K -records; Moment generating function; Moments; Truncated distributions.

1. Introduction

Kamps [15] introduced the concept of *generalized order statistics* (*gos*'s). Ordinary order statistics (*oos*'s), k -records (ordinary record values (*orv*'s) when $k = 1$), sequential order statistics, ordering via truncated distributions and censoring schemes can be discussed as special cases of the *gos*'s. Kamps's book [15] gave several applications such as a variety disciplines, recurrence

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An Improved Software Failure Model Based on Non-homogeneous Poisson Processes

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ABSTRACT Yamada *et al.* [15] suggested a stochastic model for a software failure phenomenon based on non-homogeneous Poisson process (NHPP). The model suffers from the problem of improper probability density function for the time to failure. The main concern of this paper is to address this issue. A modification of it is proposed which rids the model of the problem of improper density function. Parameters of the model are estimated by maximum likelihood (ML) estimation method. Necessary and sufficient conditions for the existence of solution of maximum likelihood equations are derived. The results of the model are applied to real-time software failure data and compared with Goel-Okumoto (G-O), Modified G-O and Yamada *et al.* models. Three real life examples are considered. In all these examples the modified Yamada *et al.* model performed better than the Yamada *et al.* model.

Keywords Software reliability, NHPP, Maximum likelihood estimation, Improper probability density function.

1. Introduction

Yamada, Ohaba and Osaki [15] offered a NHPP model in which the observed growth curve of the time to failures is S-shaped. This model is equivalent to other exponential class of NHPP models like Jelinski and Moranda [6] (J-M), Musa [10], Schneidewind [14], G-O [4], Hossain and Dahiya [5], and Dahiya-Hossain [3]. One of the basic NHPP models is the G-O model in which the failure detection rate is a constant. In the Yamada *et al.* model it is an increasing function of time. Ohba [13] model describes a software failure process with a mutual dependence of detected failures. In this process, as more and more failures are detected, more

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On Size-Biased Generalized Negative Binomial Distribution

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ABSTRACT In this paper, a size-biased generalized negative binomial distribution (SBGNBD) is defined and studied. A recurrence relationship for the moments of SBGNBD is established. The Bayes estimator for a parametric function of one parameter when other two parameters are known of size-biased generalized negative binomial distribution is derived. The prior information on one parameter may be given by a beta distribution. It has been illustrated that the parameters in the prior distribution can be assigned by a computer using Monte Carlo and R-software.

Keywords Generalized negative binomial distribution; Size-biased generalized negative binomial distribution; Zero-truncated generalized negative binomial distribution; Size-biased negative binomial distribution; Goodness of fit; Bayes estimation.

1. Introduction

Jain and Consul [21] defined generalized negative binomial distribution (GNBD). It was subsequently obtained by Consul and Shenton ([7], [8]) as a particular family of Lagrangian distribution. The parameter space of the distribution was further modified by Consul and Gupta [6] when they studied some of its interesting properties. The probability function of the GNBD is given by

$$P_1(X = x) = \frac{m}{m + \beta x} \binom{m + \beta x}{x} \alpha^x (1 - \alpha)^{m + \beta x - x}; x = 0, 1, 2, \dots \quad (1.1)$$

where $0 < \alpha < 1$, $m > 0$ and $|\alpha\beta| < 1$.

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